











CSD19533Q5A

SLPS486A - DECEMBER 2013-REVISED MAY 2014

CSD19533Q5A 100 V N-Channel NexFET™ Power MOSFET

Features

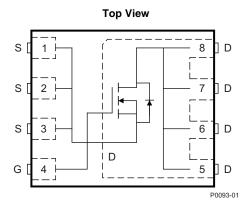
- Ultra-Low Qa and Qad
- Low Thermal Resistance
- Avalanche Rated
- Pb-Free Terminal Plating
- **RoHS Compliant**
- Halogen Free
- SON 5-mm x 6-mm Plastic Package

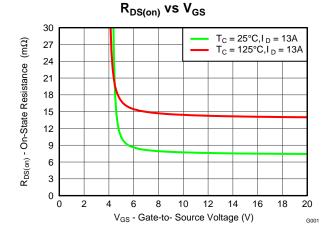
Applications

- Primary Side Telecom
- Secondary Side Synchronous Rectifier
- Motor Control

Description 3

This 100 V, 7.8 m Ω , SON 5 mm × 6 mm NexFETTM power MOSFET is designed to minimize losses in power conversion applications.





Product Summary

$T_A = 25^\circ$	С	TYPICAL VA	UNIT		
V_{DS}	Drain-to-Source Voltage		V		
Q_g	Gate Charge Total (10 V) 27				
Q_{gd}	Gate Charge Gate to Drain	4.9	nC		
D	Drain-to-Source On Resistance	V _{GS} = 6 V 8.7		mΩ	
R _{DS(on)}	Drain-to-Source On Resistance	V _{GS} = 10 V 7.8		mΩ	
V _{GS(th)}	Threshold Voltage	2.8	V		

Ordering Information⁽¹⁾

Device	Device Media Qty		Package	Ship						
CSD19533Q5A	13-Inch Reel	2500	SON 5 x 6 mm	Tape and						
CSD19533Q5AT	7-Inch Reel	250	Plastic Package	Reel						

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

T _A = 2	5°C	VALUE	UNIT
V_{DS}	Drain-to-Source Voltage	100	٧
V_{GS}	Gate-to-Source Voltage	±20	V
	Continuous Drain Current (Package limited)	100	
I _D	Continuous Drain Current (Silicon limited), $T_C = 25$ °C	75	Α
	Continuous Drain Current, T _A = 25 °C ⁽¹⁾	13	
I_{DM}	Pulsed Drain Current, T _A = 25 °C ⁽²⁾	231	Α
D	Power Dissipation ⁽¹⁾	3.2	W
P_D	Power Dissipation, T _C = 25°C	96	VV
T _J , T _{stg}	Operating Junction and Storage Temperature Range	-55 to 150	ů
E _{AS}	Avalanche Energy, single pulse I_D = 46 A, L = 0.1 mH, R_G = 25 Ω	106	mJ

- (1) Typical $R_{\theta JA}=40\,$ °C/W on a 1-inch², 2-oz. Cu pad on a 0.06-inch thick FR4 PCB.
- (2) Max $R_{\theta JC} = 1.3$ °C/W, pulse duration $\leq 100 \mu s$, duty cycle $\leq 1\%$

Gate Charge

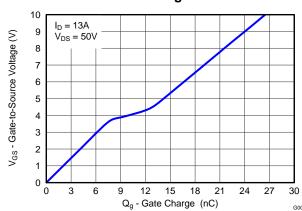




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6	Device and Documentation Support 7		7.4 Q5A Tape and Reel Information

4 Revision History

CI	hanges from Original (December 2013) to Revision A	Page
•	Added small reel order number	1
•	Increased pulsed drain current to 231A	1
•	Added line for max power dissipation with case temperature held to 25°C	1
•	Updated the pulsed drain current conditions	1
•	Fixed y-axis on Figure 1 to state that it is a normalized R _{eJC} curve	4
•	Updated the safe operating area in Figure 10	6



5 Specifications

5.1 Electrical Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS					
BV _{DSS}	Drain-to-Source Voltage	V _{GS} = 0 V, I _D = 250 μA	100			V
I _{DSS}	Drain-to-Source Leakage Current	V _{GS} = 0 V, V _{DS} = 80 V			1	μA
I _{GSS}	Gate-to-Source Leakage Current	V _{DS} = 0 V, V _{GS} = 20 V			100	nA
V _{GS(th)}	Gate-to-Source Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA	2.2	2.8	3.4	V
D. Dunin to Course On Bonistane		$V_{GS} = 6 \text{ V}, I_D = 13 \text{ A}$		8.7	11.1	mΩ
R _{DS(on)}	Drain-to-Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 13 \text{ A}$		7.8	9.4	$m\Omega$
g _{fs}	Transconductance	V _{DS} = 10 V, I _D = 13 A		63		S
DYNAMI	C CHARACTERISTICS					
C _{iss}	Input Capacitance			2050	2670	рF
C _{oss}	Output Capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 50 \text{ V}, f = 1 \text{ MHz}$		395	514	pF
C _{rss}	Reverse Transfer Capacitance			9.6	12.5	рF
R_{G}	Series Gate Resistance			1.2	2.4	Ω
Q_g	Gate Charge Total (10 V)			27	35	nC
Q_{gd}	Gate Charge Gate to Drain	V _{DS} = 50 V, I _D = 13 A		4.9		nC
Q _{gs}	Gate Charge Gate to Source	V _{DS} = 50 V, I _D = 13 A		7.9		nC
$Q_{g(th)}$	Gate Charge at V _{th}			5.7		nC
Q _{oss}	Output Charge	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$		75		nC
$t_{d(on)}$	Turn On Delay Time			6		ns
t _r	Rise Time	V _{DS} = 50 V, V _{GS} = 10 V,		6		ns
$t_{d(off)}$	Turn Off Delay Time	$I_{DS} = 13 \text{ A}, R_G = 0 \Omega$		16		ns
t _f	Fall Time			5		ns
DIODE C	CHARACTERISTICS					
V_{SD}	Diode Forward Voltage	I _{SD} = 13 A, V _{GS} = 0 V		0.8	1.0	V
Q_{rr}	Reverse Recovery Charge	V _{DS} = 50 V, I _F = 13 A,		163		nC
t _{rr}	Reverse Recovery Time	di/dt = 300 A/µs		62		ns

5.2 Thermal Information

(T_A = 25°C unless otherwise stated)

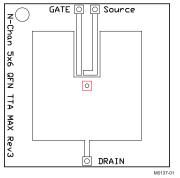
	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-Case Thermal Resistance ⁽¹⁾			1.3	°C/W
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance ⁽¹⁾⁽²⁾			50	C/VV

⁽¹⁾ R_{θJC} is determined with the device mounted on a 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inches x 1.5-inches (3.81-cm x 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB. R_{θJC} is specified by design, whereas R_{θJA} is determined by the user's board design.

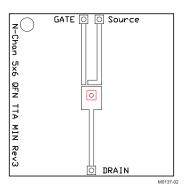
(2) Device mounted on FR4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.

Product Folder Links: CSD19533Q5A





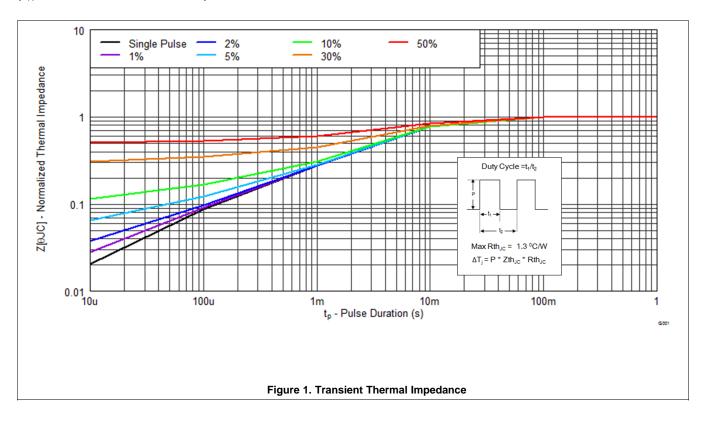
Max $R_{\theta JA} = 50^{\circ} C/W$ when mounted on 1 inch² (6.45 cm²) of 2-oz. (0.071-mm thick) Cu.



Max $R_{\theta JA} = 115^{\circ} C/W$ when mounted on a minimum pad area of 2-oz. (0.071-mm thick) Cu.

5.3 Typical MOSFET Characteristics

(T_A = 25°C unless otherwise stated)



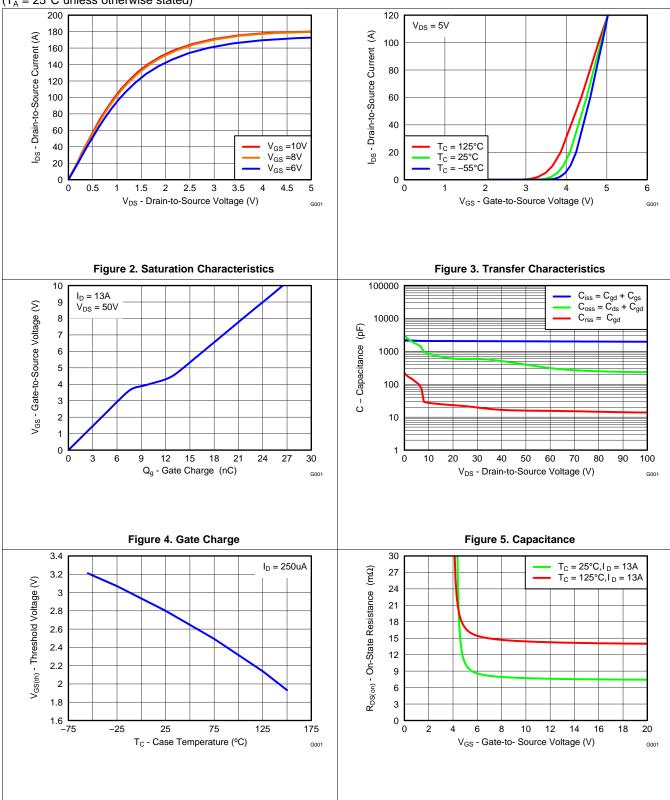
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Typical MOSFET Characteristics (continued)

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$



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Figure 6. Threshold Voltage vs Temperature

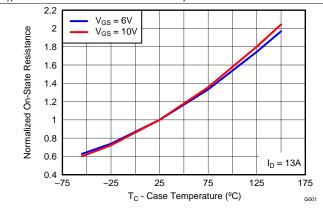
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Figure 7. On-State Resistance vs Gate-to-Source Voltage



Typical MOSFET Characteristics (continued)

(T_A = 25°C unless otherwise stated)



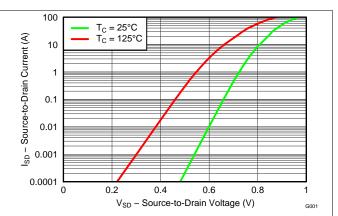
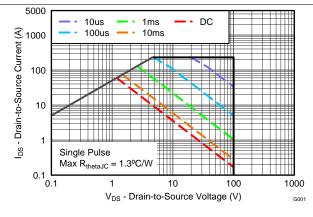


Figure 8. Normalized On-State Resistance vs Temperature





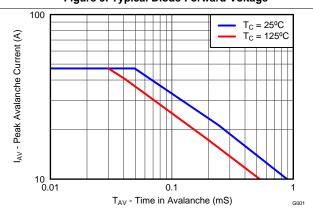


Figure 10. Maximum Safe Operating Area



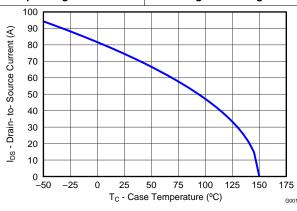


Figure 12. Maximum Drain Current vs Temperature



6 Device and Documentation Support

6.1 Trademarks

NexFET is a trademark of Texas Instruments.

6.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

6.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms and definitions.

Product Folder Links: CSD19533Q5A



7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

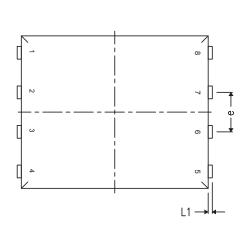
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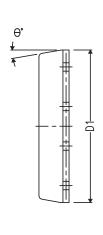
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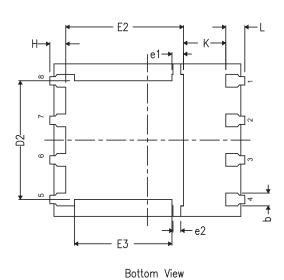


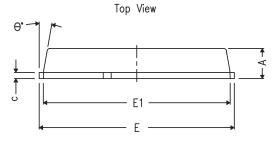
7.1 Q5A Package Dimensions





Side View





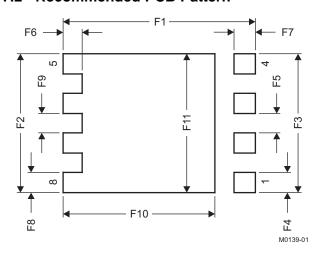
Front View

DIM	MILLIMETERS							
DIM	MIN	NOM	MAX					
А	0.90	1.00	1.10					
b	0.33	0.41	0.51					
С	0.20	0.25	0.34					
D1	4.80	4.90	5.00					
D2	3.61	3.81	4.02					
E	5.90	6.00	6.10					
E1	5.70	5.75	5.80					
E2	3.38	3.58	3.78					
E3	3.03	3.13	3.23					
е	1.17	1.27	1.37					
e1	0.27	0.37	0.47					
e2	0.15	0.25	0.35					
Н	0.41	0.56	0.71					
K	1.10	-	_					
L	0.51	0.61	0.71					
L1	0.06	0.13	0.20					
θ	0°	_	12°					

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7.2 Recommended PCB Pattern

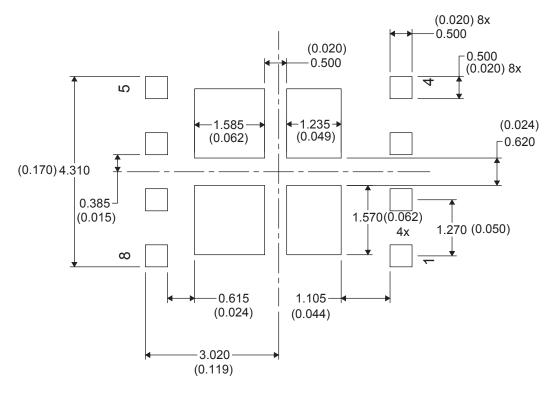


DIM	MILLIM	ETERS	INCHES			
DIM	MIN	MAX	MIN	MAX		
F1	6.205	6.305	0.244	0.248		
F2	4.46	4.56	0.176	0.18		
F3	4.46	4.56	0.176	0.18		
F4	0.65	0.7	0.026	0.028		
F5	0.62	0.67	0.024	0.026		
F6	0.63	0.68	0.025	0.027		
F7	0.7	0.8	0.028	0.031		
F8	0.65	0.7	0.026	0.028		
F9	0.62	0.67	0.024	0.026		
F10	4.9	5	0.193	0.197		
F11	4.46	4.56	0.176	0.18		

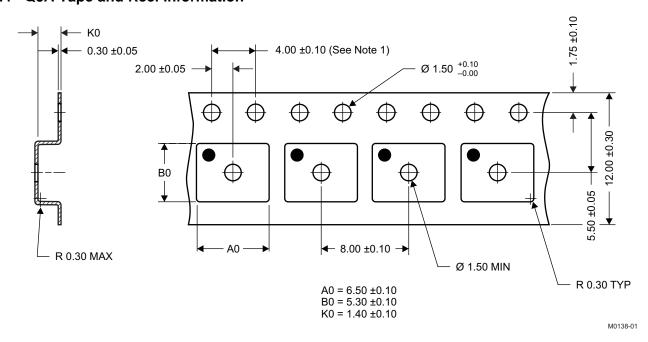
For recommended circuit layout for PCB designs, see application note SLPA005 – Reducing Ringing Through PCB Layout Techniques.



7.3 Recommended Stencil Opening



7.4 Q5A Tape and Reel Information



Notes:

- 1. 10-sprocket hole-pitch cumulative tolerance ±0.2
- 2. Camber not to exceed 1 mm in 100 mm, noncumulative over 250 mm
- 3. Material: black static-dissipative polystyrene
- 4. All dimensions are in mm (unless otherwise specified)
- 5. A0 and B0 measured on a plane 0.3 mm above the bottom of the pocket

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PACKAGE OPTION ADDENDUM

29-Jun-2018

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CSD19533Q5A	ACTIVE	VSONP	DQJ	8	2500	Pb-Free (RoHS Exempt)	CU SN	Level-1-260C-UNLIM	-55 to 150	CSD19533	Samples
CSD19533Q5AT	ACTIVE	VSONP	DQJ	8	250	Pb-Free (RoHS Exempt)	CU SN	Level-1-260C-UNLIM	-55 to 150	CSD19533	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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